

Transaction Information

Tool ID	
Tool Status	Connected
Location	
Wafer Size	200 mm
Fab Section	Defect Detection
Tool Available Date	

General Product Information

Vendor Supplier	KLA
Model	KLA2138-IS
Vintage	1998
Serial No	
Asset Description	PTE0002
Software Version	KLA2138-IS
CIM	SECS
Process	DEFECT INSPECTION

Hardware Configuration

System Type	Description	Quantity
Main System	Main body	
Handler System	STAGE	1
Factory Interface	SMIF	2
Others		
Options System		

Description	Quantity
NONE	